

**PART NUMBER**

**CH390/L2S**

**COMPONENT**

**ISSUE 1**

**SPECIFICATION**

**September 2013**

**Component Specification  
For Ceramic Hermetically Sealed, Radiation Hard  
High Gain Optocoupler**



**M1077 IECQ**



Further copies of this document may be obtained from:

ISOCOM LIMITED  
WASHINGTON, UK  
NE38 0AH  
[www.isocom.uk.com](http://www.isocom.uk.com)

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Ceramic Hermetically Sealed, Radiation Hard High Gain Optocoupler

- CH390
- CH390/L2
- CH390/L2S

### Features

- Released to European Standard and Complies to Mil Std
- High Current Transfer Ratio (Typically 1000%)
- Displacement Damage Tested to  $3 \text{ MEV} \times 10^{12}$
- Hermetically Sealed
- High Withstand Test Voltage
- 5 Pin Hybrid Package
- Low Input Requirements 0.5mA

### Applications

- Space Radiation Equipment
- Military, high reliability system
- Medical instruments
- Mos, Cmos Applications
- Logic Interfacing
- Data Transmission
- Power Supply
- Modems

### Description

These devices are single, hermetically sealed optically coupled isolators. Each channel is composed of a Gallium Arsenide infra-red emitting diode and a high gain photon detector. The high gain output stage features an open collector output providing both lower output saturation and higher speed of operation than is possible with conventional photo-darlington type couplers. The CH390 series are being used in environments encountered by space applications. It is manufactured to meet the JANS standard in conjunction with MIL-PRF-19500 procedures (please see next page for all other applicable specifications). Package styles for this device include 5 Pin Hybrid Package with surface mount, solder dip option available. These packages have a shield effect to cut off ambient light as they are designed for high density mounting applications.

Therefore absolute maximum ratings, recommended operating conditions, electrical specifications and performance characteristics are identical for all units. Any exceptions, due to packaging variations and limitations, are as noted.

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Standards

The following specifications have been included in the manufacturing of this product:

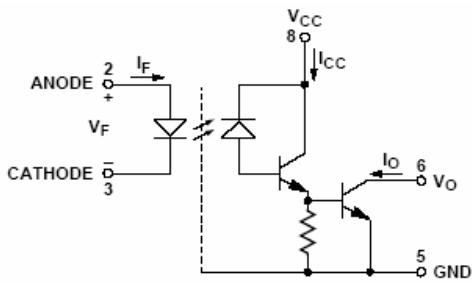
### **Military Compliance Specifications**

MIL-PRF-19500 – General Specification for Discrete Semiconductor Devices  
IECQ – M1077

### **Military Compliance Standards**

MIL-STD-202 – Test Method Standard Electronic and Electrical Component Parts  
MIL-STD-883 – Test Method Standard Microcircuits  
MIL-STD-750 – Test Methods for Semiconductor Devices  
ISO 9001:2008 – Manufacturing of Optocouplers and Optoelectronic components.

## Single Channel Schematic



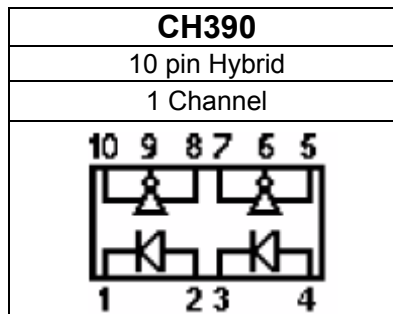
For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

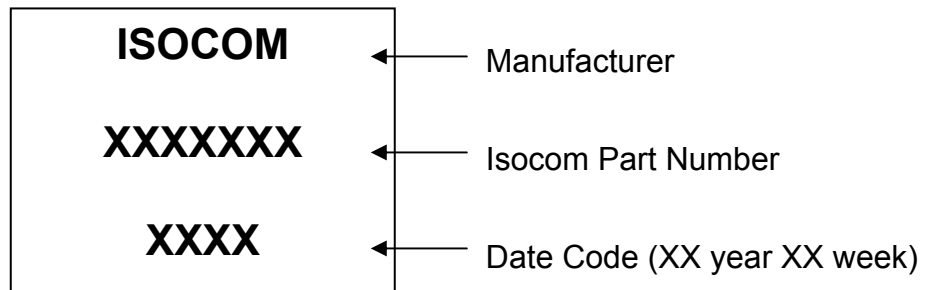
## Selection Guide Package Styles and Configuration Options

Package	5 pin Hybrid
Lead Style	
Channels	1
Common Channel Wiring	
<b>Isocom Part Number and Options</b>	
Commercial	CH390
Defense Screen Level	CH390/L2
Space Screen Level	CH390/L2S
Standard Gold Plate Finish	Gold Plate
Solder Dipped	Option 20

## Functional Diagrams



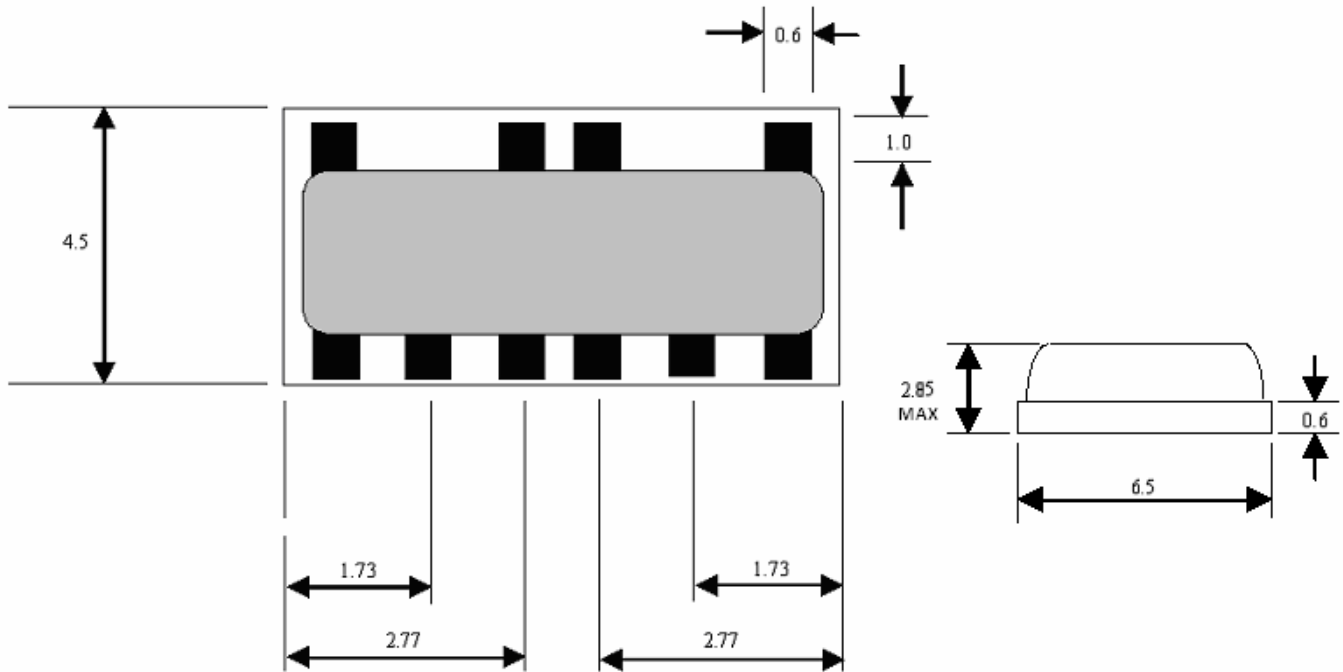
## Device Marking



For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
 Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Outline Drawings



## Absolute Maximum Ratings

T<sub>A</sub> = 25°C U.O.S.

Storage Temperature	-65°C to +150°C	
Operating Temperature	-55°C to +125°C	
Lead Soldering Temperature	260°C 1.6mm from case for 10S	
Input-to-Output Isolation Voltage	↑1000VDC	

### **Input Diode**

Peak Forward Current	20mA	≤ 1 mS duration, 500pps
Average Forward Current	10mA	
Reverse Voltage	5V	

### **Output Transistor**

Supply Voltage	0.5V to 20V	
Average Current	40mA	
Power Dissipation	50mW	

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
 Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Electrical Characteristics

$T_A = 25^\circ\text{C}$  U.O.S.

Parameter	Symbol	Test Conditions	Min	Type	Max	Units
Current Transfer Ratio (see notes 4&5)	CTR	$V_{CC} = 4.5\text{V}, V_O = 0.4\text{V}, I_F = 0.5\text{mA}$	300	700	-	%
		$V_{CC} = 4.5\text{V}, V_O = 0.4\text{V}, I_F = 1.6\text{mA}$	200	1000	-	%
		$V_{CC} = 5\text{V}, V_O = 0.4\text{V}, I_F = 5\text{mA}$	200	600	-	%
Logic low output voltage (see note 4)	$V_{OL}$	$V_{CC} = 4.5\text{V}, I_F = 0.5\text{mA}, I_{OL} = 1.5\text{mA}$	-	0.1	0.4	V
		$V_{CC} = 4.5\text{V}, I_F = 5\text{mA}, I_{OL} = 10\text{mA}$	-	0.12	0.4	V
Logic high output current	$I_{OH}$	$I_F = 2\mu\text{A}, V_O = V_{CC} = 5.5\text{V}$	-	0.001	250	$\mu\text{A}$
Logic high supply current	$I_{CCH}$	$I_F = 0, V_{CC} = 18\text{V}$	-	0.1	40	$\mu\text{A}$
Logic low supply current (see note 4)	$I_{CCL}$	$V_{CC} = 18\text{V}, I_F = 1.6\text{mA}$	-	1.4	4	mA
Input forward voltage (see note 4)	$V_F$	$I_F = 1.6\text{mA}$	-	1.45	1.9	V
Input-Output Insulation Leakage Current (see note 7 & 13)	$I_{I-O}$	$RH = 45\%, t = 5\text{S}, V_{I-O} = 1500\text{Vdc}$	-	-	1.0	$\mu\text{A}$
Input reverse breakdown (see note 4)	$V_{BR}$	$I_R = 10\mu\text{A}$	5	-	-	V
Propagation Delay H-L (see note 4)	$t_{PHL}$	$R_L = 4.7\text{K}\Omega, V_{CC} = 5\text{V}, I_F = 0.5\text{mA}$	-	35	100	$\mu\text{S}$
		$R_L = 680\Omega, V_{CC} = 5\text{V}, I_F = 5\text{mA}$	-	3	12	$\mu\text{S}$
Propagation Delay L-H (see note 4)	$t_{PLH}$	$R_L = 4.7\text{K}\Omega, V_{CC} = 5\text{V}, I_F = 0.5\text{mA}$	-	8	60	$\mu\text{S}$
		$R_L = 680\Omega, V_{CC} = 5\text{V}, I_F = 5\text{mA}$	-	-	60	$\mu\text{S}$
Common Mode Transient Immunity at Logic High Output (see note 4, 10 & 12)	$CM_H$	$V_{CC} = 5\text{V}, I_F = 0\text{mA}, V_{cm} = 50\text{V}_{p-p}, R_L = 2.2\text{K}\Omega$	500	-1000	-	$\text{V}/\mu\text{S}$
Common Mode Transient Immunity at Logic Low Output (see note 4, 10 & 12)	$CM_L$	$V_{CC} = 5\text{V}, I_F = 1.6\text{mA}, V_{cm} = 50\text{V}_{p-p}, R_L = 2.2\text{K}\Omega$	-500	-1000	-	$\text{V}/\mu\text{S}$

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Typical Characteristics

$T_A = 25^\circ\text{C}$

Parameter	Symbol	Test Conditions	Notes	Min	Type	Max	Units
Resistance	$R_{IO}$	$V_{10} = 500\text{Vdc}$	4 & 8	-	$10^{12}$	-	$\Omega$
Capacitance	$C_{IO}$	$f = 1\text{MHz}$	4 & 8	-	1.5	-	pF
Input Capacitance	$C_{IN}$	$f = 1\text{MHz}, V_F = 0$	4	-	60	-	pF
Temperature Coefficient of Forward Voltage	$\frac{\Delta V_F}{\Delta T_A}$	$I_F = 1.6\text{mA}$	1	-	-1.8	-	mV/ $^\circ\text{C}$
Input-Input Insulation Leakage Current	$I_{I-I}$	45% Relative Humidity $V_{II} = 500\text{Vdc}, t = 5\text{S}$	9	-	0.6	-	nA
Resistance	$R_{I-I}$	$V_{II} = 500\text{Vdc}$	9	-	$10^{12}$	-	$\Omega$
Capacitance	$C_{I-I}$	$f = 1\text{MHz}$	9	-	1	-	pF

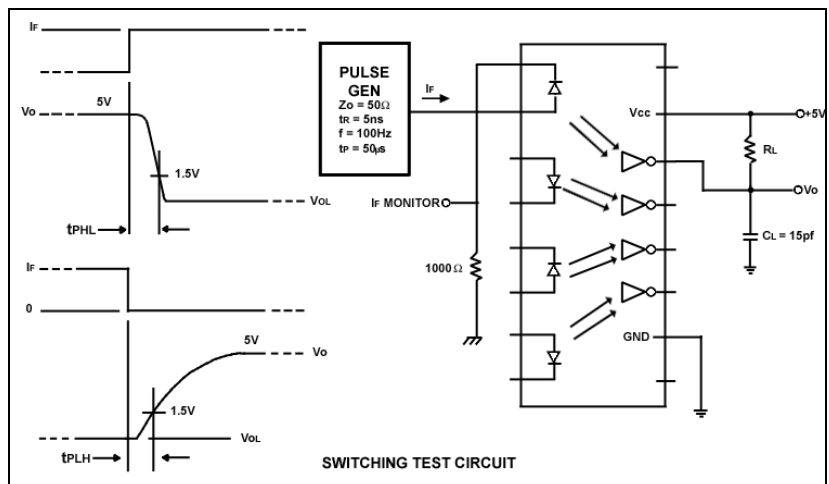
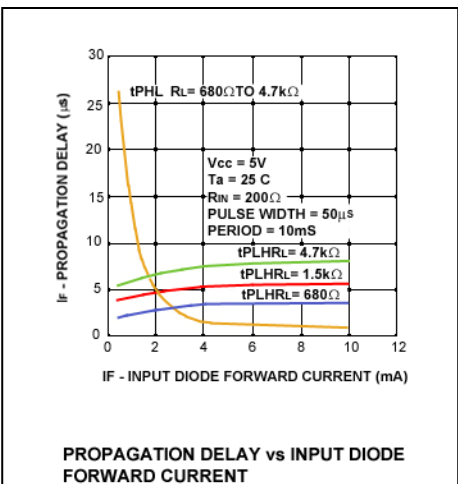
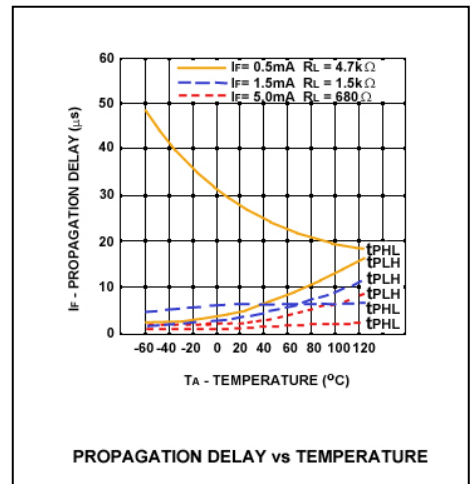
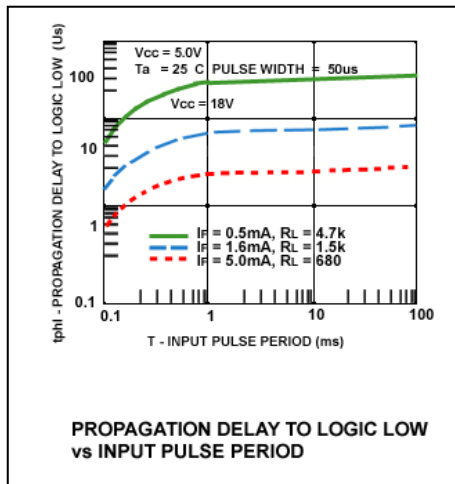
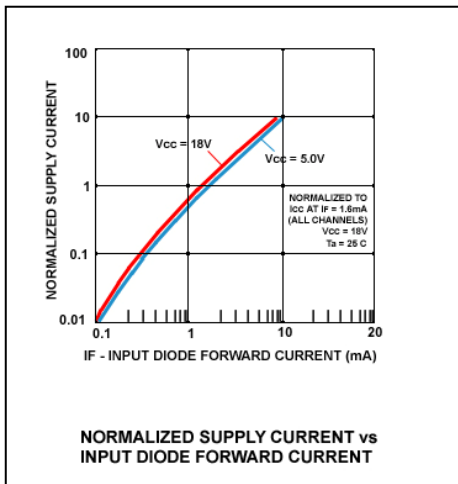
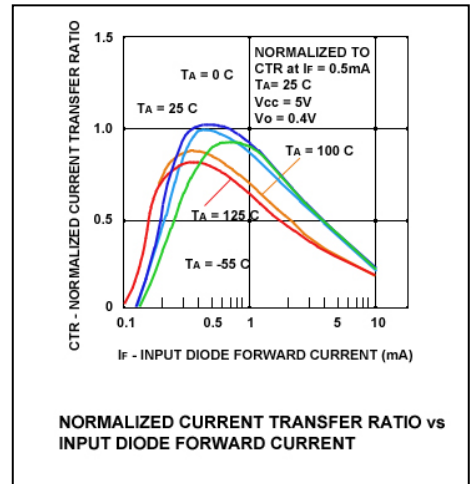
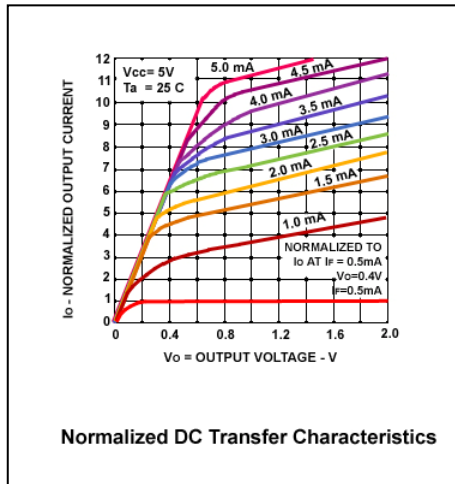
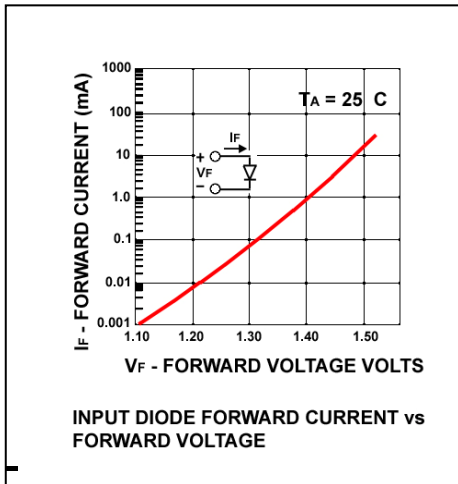
### Notes:

1. The ground pin should be the most negative voltage at the detector side. Keeping  $V_{CC}$  as low as possible, but greater than 2.0V, will provide lowest total  $I_{OH}$  over temperature.
2. Output power is collector output plus one fourth of total supply power. Derate at 1.66mW/ $^\circ\text{C}$  above 110 $^\circ\text{C}$ .
3. Derate  $I_F$  at 0.33mA/ $^\circ\text{C}$  above 110 $^\circ\text{C}$ .
4. Each channel.
5. Current Transfer Ratio is defined as the ratio of output collector current,  $I_O$ , to the forward LED input current,  $I_F$ , times 100%.
6.  $I_{OHX}$  is the leakage current resulting from channel to channel optical crosstalk.  $I_F = 2\mu\text{A}$  for channel under test. For all other channels,  $I_F = 10\text{mA}$ .
7. Input pins are shorted together, and output pins are shorted together.
8. Measured between the LED anode and cathode shorted together and pins at output shorted together.
9. Measured between adjacent input pairs shorted together.
10.  $CM_H$  is the maximum tolerable common mode transient to assure that the output will remain in a high logic state (i.e.,  $V_O > 2.0\text{V}$ ).
11.  $CM_L$  is the maximum tolerable common mode transient to assure that the output will remain in the logic low state (i.e.,  $V_O < 0.8\text{V}$ ).
12. In applications where  $dV/dt$  may exceed 50,000V/ $\mu\text{S}$  (such as a static discharge), a series resistor,  $R_{CC}$ , should be included to protect the detector IC's from destructively high surge currents. The recommended value is
 
$$R_{CC} = \frac{1\text{V}}{0.6I_F(\text{mA})} \text{ k}\Omega$$
13. This is a momentary withstand test, not an operating condition.

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Electrical Characteristics



For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055



## GROUP TESTING to MIL-STD 750

GROUP	TEST	MIL-STD-750	READ AND RECORD
<b>Group A</b>			
SG1	Visual inspection & mechanical dimensions	Method 2071	
SG2	DC static test at 25°C		yes
SG3	DC static test at 125°C and -55°C		yes
SG4	Dynamic test at 25°C		yes
<b>Group B</b>			
SG 1	Physical dimensions	Method 2066	
SG 2	Solderability	Method 2026	
	Resistance to solvents	Method 1022	
SG 3	Thermal Shock	Method 1056 Cond. B, 25 cycles	
	Temperature cycling	Method 1051, 100 cycles, -55/+125°C	
	Hermetic seal fine and gross leak	Method 1071, Cond. H (fine), Cond. C (gross)	
	<b>Electrical measurement</b>	pre and post	yes
	Decap internal visual inspection	2075	
	<b>Bond strength</b>	Method 2037, Cond. D	yes
	<b>Die shear</b>	Method 2017	yes
SG 4	Intermittent operation life	Method 1037, 1042, Cond D, Tab.5-5	
	Hermetic seal fine and gross leak	Method 1071, Cond. H (fine), Cond. C (gross)	
	<b>Electrical measurement</b>	pre and post	yes
	<b>Bond strength</b>	Method 2037, Cond. D	yes
SG 5	Acc. steady-state operation life	Method 1027	
	<b>Electrical measurement</b>	pre and post	yes
	<b>Bond strength</b>	Method 2037, Cond. D	yes
<b>Group C</b>			
SG 2	Thermal Shock	Method 1056, Cond. B, 25 shocks	
	Temperature cycling	Method 1051, Cond. C, -55/+125°C, 25 cycles (total 45 cycles including screening)	
	Hermetic seal fine and gross leak	Method 1071, Cond. H (fine), Cond. C (gross)	
	Moisture resistance	Method 1021	
	<b>Electrical measurement</b>	pre and post	yes
SG 3	Mechanical shock	Method 2016, non-operating, 1500 G, 0.5 ms, 5 blows in each orientation (X1,Y1,Z1)	
	Vibration	Method 2056	
	Constant acceleration	Method 2006, at a peak level of 5000 G	
	<b>Electrical measurement</b>	pre and post	yes
SG 6	Steady state operating life Not required as B5 is available on same lot		

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
 Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## 100% SCREENING to MIL-STD 750

TEST	MIL-STD-750	READ AND RECORD?
Internal Visual	2072	
<b>Sealing</b>		
(Fine Leak)	1071, Condition H1	
(Gross Leak)	1071, Condition C	
Temp Cycling	1051, Condition B-55/+125°C, 20 Cycles.	
Const. Acceler	2006, 5000G, Y1 only.	
PIND	2052, Condition A	
Radiography	2076	
Initial Electrical	125°C, -55°C, 25°C	R & R
HTRB	1039	
Interim Electrical	25°C only	R & R
Burn-In	1039	
Final Electrical	125°C, -55°C, 25°C	R & R
PDA	Max. 5%, pre/post B1 electrical and delta at RT only	Calculate & R
(Fine Leak)	1071, Condition H1	
(Gross Leak)	1071, Condition C	
<b>Solder Dip</b>		
Fine Leak	1071, Condition H1	
Gross Leak	1071, Condition C	

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
 Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Space Qualification PROCESS FLOW CHART FOR PACKAGED DEVICES



For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055

## Space Qualification PROCESS FLOW CHART FOR PACKAGED DEVICES

Group B Testing	*MIL-STD-883	*MIL-STD-750
Physical Dimensions	Method 2016	Method 2066
Solderability	Method 2003	Method 2023
Resistance to Solvents	Method 2015	Method 1022
Temperature Cycling	Method 1010	Method 1051
• <i>Military Grade</i>	25 cycles	25 cycles
• <i>Space Grade</i>	50 cycles	50 cycles
Steady State Life (Tch 175°C / 340hr minimum)	Method 1005	Method 1027
DPA	*MIL-STD-1580A	*MIL-STD-1580A
	*Unless otherwise indicated	*Unless otherwise indicated

Environmental & Mechanical Testing Specifications		
	*MIL-STD-883	*MIL-STD-750
Hermetic Seal Test	Method 1014	Method 1071
• <i>Fine Leak</i>	Condition A1	Condition G or H
• <i>Gross Leak</i>	Condition C	Method 1051
Temperature Cycle ( <i>Standard Military Level</i> )	Method 1010, Condition C	Method 1051, Condition C
Temperature Cycle ( <i>Standard Space Level</i> )	Method 1010, Condition C	Method 1051, Condition C
Constant Acceleration	Method 2001	Method 2006
PIND Test	Method 2020	Method 2052, Condition A
RTH Measurement	Method 1012	
HTRB ( <i>High Temperature Reverse Bias</i> )	Method 1015, Condition A	Method 1042, Condition B
DPA	*MIL-STD-1580A	*MIL-STD-1580A
	*Unless otherwise indicated	*Unless otherwise indicated

Inspection Table		
COMMERCIAL	MILITARY	HI-REL / SPACE
AQL Sampling Plan	MIL-STD-883, Method 2010, Class Level B	MIL-STD-883, Method 2010, Class Level S
Isocom Internal Specifications	MIL-STD-750, Method 2070, 2071,2072	MIL-STD-750, Method 2070, 2071,2072

For sales enquiries, or further information, please contact our sales office at:

Isocom Ltd, 48, Hutton Close, Crowther Industrial Estate, Washington, Tyne and Wear, UK, NE38 0AH  
Tel: +44 0191 4166 546 Fax: +44 0191 4155 055